

January 1995 Revised May 1999

## 74F2240

# Octal Buffer/Line Driver with 25 $\Omega$ Series Resistors in the Outputs

#### **General Description**

The 74F2240 is an inverting octal buffer and line driver designed to drive capacitive inputs of MOS memory devices, address and clock lines or act as a low undershoot general purpose bus driver.

The  $25\Omega$  series resistor in the outputs reduces undershoot and ringing and eliminates the need for external resistors.

#### **Features**

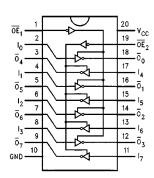
- 3-STATE outputs drive bus lines or buffer memory address registers
- Outputs sink 12 mA and source 15 mA
- $\blacksquare$  25 $\Omega$  series resistors in outputs eliminate the need for external resistors
- Designed to drive the capacitive inputs of MOS devices
- Guaranteed 4000V minimum ESD protection

## **Ordering Code:**

Order Number	Package Number	Package Description					
74F2240SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide					
74F2240QC	V20A	20-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.350 Square					

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

# **Connection Diagram**



### **Truth Table**

OE <sub>1</sub>	D <sub>1n</sub>	O <sub>1n</sub>	OE <sub>2</sub>	D <sub>2n</sub>	O <sub>2n</sub>
Н	Х	Z	Н	Х	Z
L	Н	L	L	Н	L
L	L	Н	L	L	Н

## **Unit Loading/Fan Out**

Pin	Description	U.L.	Output	
Names	Description	HIGH/LOW	I <sub>OH</sub> /I <sub>OL</sub>	
$\overline{OE}_1, \overline{OE}_2$	3-STATE Output			
	Enable Input		20 μA/–1 mA	
	(Active LOW)			
I <sub>0</sub> - I <sub>7</sub>	Inputs	1.0/1.667	20 μA/–1 mA	
$\overline{O}_0 - \overline{O}_7$	Outputs	750/20	-15 mA/12 mA	

## **Absolute Maximum Ratings**(Note 1)

**Recommended Operating Conditions** 

Free Air Ambient Temperature

Supply Voltage

-65°C to + 150°C Storage Temperature Ambient Temperature under Bias  $-55^{\circ}$  to  $+125^{\circ}C$ Junction Temperature under Bias -55°C to +150°C

V<sub>CC</sub> Pin Potential to Ground Pin -0.5V to +7.0V Input Voltage (Note 2) -0.5V to +7.0V

Input Current (Note 2)  $-30\ mA$  to  $+5.0\ mA$ 

Voltage Applied to Output In HIGH State (with  $V_{CC} = 0V$ )

Standard Output -0.5 V to  $V_{\mbox{\footnotesize CC}}$ 3-STATE Output -0.5V to +5.5V

in LOW State (Max) twice the rated  $I_{OL}$  (mA) ESD Last Passing Voltage (Min) 4000V

Current Applied to Output

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

 $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ 

+4.5V to +5.5V

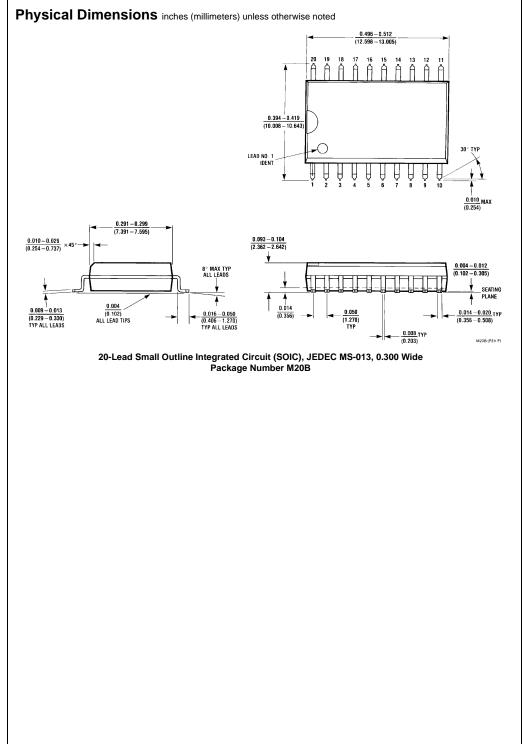
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

## **DC Electrical Characteristics**

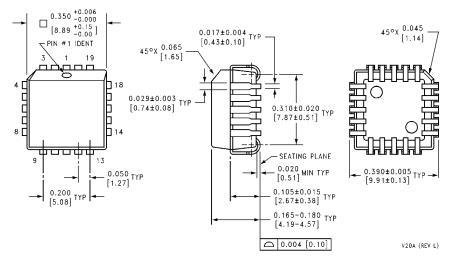
Symbol	bol Parameter		Min	Тур	Max	Units V <sub>CC</sub>		Conditions
V <sub>IH</sub>	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage				8.0	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage	)			-1.2	V	Min	$I_{IN} = -18 \text{ mA}$
V <sub>OH</sub>	Output HIGH	10% V <sub>CC</sub>	2.4			V	Min	$I_{OH} = -3 \text{ mA}$
	Voltage	10% V <sub>CC</sub>	2.0			V	IVIIII	$I_{OH} = -15 \text{ mA}$
V <sub>OL</sub>	Output LOW Voltage	10% V <sub>CC</sub>			0.75	V	Min	I <sub>OL</sub> = 12 mA
I <sub>IH</sub>	Input HIGH Current				5.0	μΑ	Max	V <sub>IN</sub> = 2.7V
I <sub>BVI</sub>	Input HIGH Current Break	down Test			7.0	μА	Max	V <sub>IN</sub> = 7.0V
I <sub>CEX</sub>	Output HIGH Leakage Cur	rent			50	μА	Max	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage		4.75			V	0.0	I <sub>ID</sub> = 1.9 μA
	Test		4.75					All Other Pins Grounded
I <sub>OD</sub>	Output Leakage				3.75	μА	0.0	V <sub>IOD</sub> = 150 mV
	Circuit Current				3.73	μΑ	0.0	All Other Pins Grounded
I <sub>IL</sub>	Input LOW				-1.0	mA	Max	V <sub>IN</sub> = 0.5V
	Current			$(\overline{OE}_1, \overline{OE}_2, D_n)$				
l <sub>ozh</sub>	Output Leakage Current				50	μΑ	Max	V <sub>OUT</sub> = 2.7V
I <sub>OZL</sub>	Output Leakage Current				-50	μΑ	Max	V <sub>OUT</sub> = 0.5V
los	Output Short-Circuit Currer	nt	-100		-225	mA	Max	V <sub>OUT</sub> = 0V
l <sub>zz</sub>	Bus Drainage Test				500	μΑ	0.0	V <sub>OUT</sub> = 5.25V
ССН	Power Supply Current			16	29	mA	Max	V <sub>O</sub> = HIGH
I <sub>CCL</sub>	Power Supply Current			47	75	mA	Max	$V_O = LOW$
I <sub>CCZ</sub>	Power Supply Current			45	63	mA	Max	V <sub>O</sub> = HIGH Z

# **AC Electrical Characteristics**

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units	
		Min	Тур	Max	Min	Max		
t <sub>PLH</sub>	Propagation Delay	3.0	4.9	7.5	3.0	7.5	ns	
t <sub>PHL</sub>	Data to Output	2.0	3.7	6.0	2.0	6.0		
t <sub>PZH</sub>	Output Enable Time	2.0	3.9	6.5	2.0	7.0	ns	
t <sub>PZL</sub>		4.0	6.7	9.5	4.0	10.0	110	
t <sub>PHZ</sub>	Output Disable Time	2.0	4.1	6.5	2.0	7.0	ns	
t <sub>PLZ</sub>		2.0	4.9	8.5	2.0	9.5		



#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



20-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.350 Square Package Number V20A

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